

650V N-Channel MOSFET

General Features

- **Advanced Planar Process**
- $R_{DS(ON),typ.}$ =350 m Ω @ V_{GS} =10V
- Low Gate Charge Minimize Switching Loss
- Rugged Poly silicon Gate Structure

Absolute Maximum Ratings

Applications

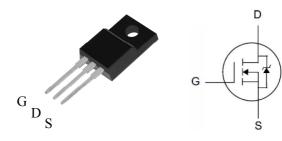
- **BLDC Motor Driver**
- Electric Welder
- High Efficiency SMPS

Ordering Information

Part Number	Package	Brand
PTA22N65	TO-220F	Z

Lead Free Package and Finish

BV _{DSS}	R _{DS(ON),typ.}	I _D
650V	$350 m\Omega$	22A



TO-220F Package

T_C=25 °C unless otherwise specified

Symbol	Parameter	PTA22N65	Unit
V _{DSS}	Drain-to-Source Voltage	650	V
V_{GSS}	Gate-to-Source Voltage	±30	V
1	Continuous Drain Current	22	
I _D	Continuous Drain Current @ Tc=100℃	14	Α
I _{DM}	Pulsed Drain Current at V _{GS} =10V ^[2,4]	88	
E _{AS}	Single Pulse Avalanche Energy	800	mJ
dv/dt	Peak Diode Recovery dv/dt ^[3]	5.0	V/ns
D	Power Dissipation	75	W
P_D	Derating Factor above 25℃	0.598	W/℃
T _L T _{PAK}	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300 260	${\mathbb C}$
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to 150	

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	PTA22N65	Unit
R _{eJC}	Thermal Resistance, Junction-to-Case	1.67	200 001
$R_{ heta JA}$	Thermal Resistance, Junction-to-Ambient	100	℃/₩



Electrical Characteristics

OFF Characteristics T_J =25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	650	-		٧	V _{GS} =0V, I _D =250uA
	Drain-to-Source Leakage Current			1	uA	V _{DS} =650V, V _{GS} =0V
I _{DSS}				125		V _{DS} =520V, V _{GS} =0V, T _J =125℃
	Cato to Source Leakage Current			+100	nA	V _{GS} =+30V, V _{DS} =0V
I _{GSS}	Gate-to-Source Leakage Current			-100	ПА	V _{GS} =-30V, V _{DS} =0V

ON Characteristics

T_J =25 ℃ unless otherwise specified

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Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R _{DS(ON)}	Static Drain-to-Source On-Resistance		350	450	mΩ	V _{GS} =10V, I _D =11A
$V_{\text{GS}(\text{TH})}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS}=V_{GS}$, $I_{D}=250uA$
g FS	Forward Transconductance		33		S	V _{DS} =25V, I _D =11A

Dynamic Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C _{iss}	Input Capacitance		3500			
C _{rss}	Reverse Transfer Capacitance		240		pF	V_{GS} =0V, V_{DS} =25V, f=1.0MH _Z
C _{oss}	Output Capacitance		255			
Qg	Total Gate Charge		65			
Q _{gs}	Gate-to-Source Charge		19		nC	V_{DD} =325V, I_{D} =22A, V_{GS} =0 to 10V
Q_{gd}	Gate-to-Drain (Miller) Charge		17			

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		46			V _{DD} =325V, I _D =11A,
trise	Rise Time		115			
td(OFF)	Turn-Off Delay Time		92		ns	V _{GS} = 10V R _G =25Ω
t fall	Fall Time		105			



Source-Drain Body Diode Characteristics

 T_J =25 $^{\circ}$ C unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I _{SD}	Continuous Source Current ^[2]		I	22	۸	Integral PN-diode in
I _{SM}	Pulsed Source Current ^[2]			88	Α	MOSFET
V _{SD}	Diode Forward Voltage		-	1.5	V	I _S =22A, V _{GS} =0V
trr	Reverse recovery time		625		ns	V _{GS} =0V ,I _F =22A,
Qrr	Reverse recovery charge		5.0		uC	dir/dt=100A/μs

Note:

^[1] T_J =+25°C to +150°C .

^[2] Silicon limited current only.
[3] Package limited current.

^[4] Repetitive rating; pulse width limited by maximum junction temperature. [5] Pulse width≤380µs; duty cycle≤2%.



Typical Characteristics

Figure 1. Maximum Transient Thermal Impedance

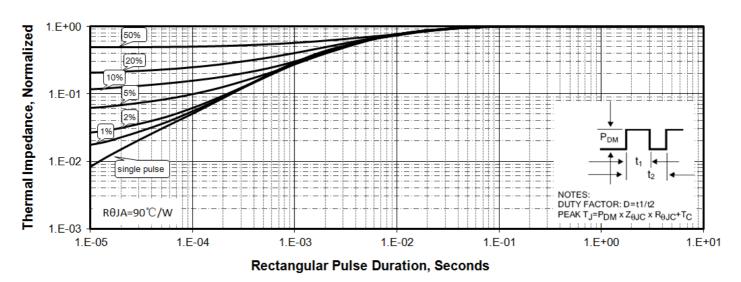


Figure 2 . Max. Power Dissipation vs Case Temperature

100 90 80 70 60 10 0 25 50 75 100 125 150 Tc, Case Temperature, °C

Figure 3 .Maximum Continuous Drain
Current vs Tc

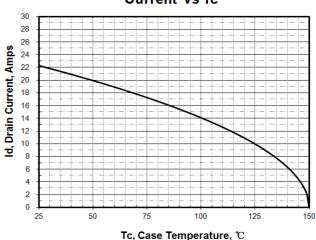


Figure 4. Output Characteristics

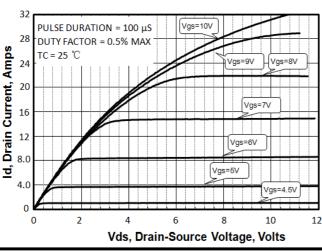
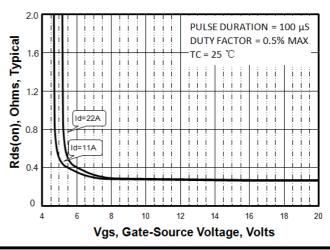


Figure 5. Rdson vs Gate Voltage





Typical Characteristics(Cont.)



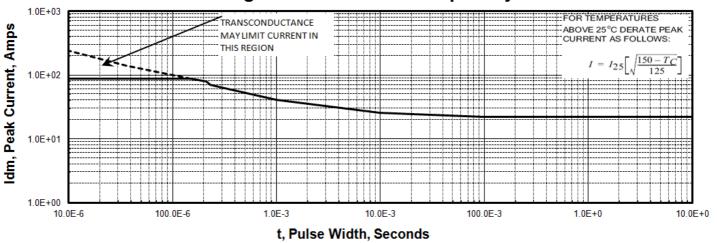


Figure 7. Transfer Characteristics

ld, Drain to Source Current, Amps PULSE DURATION = 10 μS 10 6.0 4.0 2.0 0 3.0 6.0 7.0 8.0 Vgs, Gate to Source Voltage, Volts

Figure 9. Drain to Source ON Resistance vs **Drain Current**

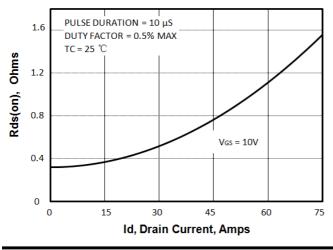


Figure 8. Unclamped Inductive Switching Capability

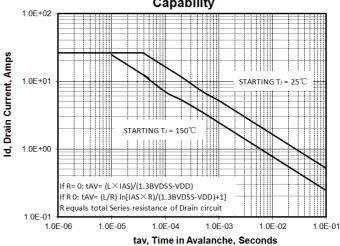
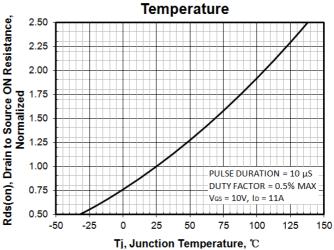


Figure 10. Rdson vs Junction **Temperature**





Typical Characteristics(Cont.)

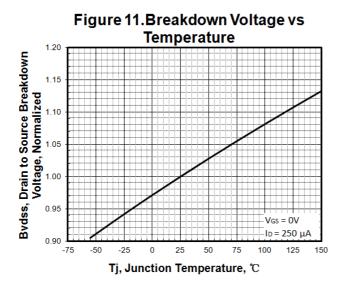
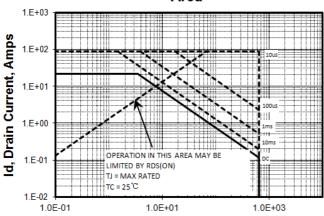


Figure 13 . Maximum Safe Operating



Vds, Drain Source Voltage, Volts

Figure 15. Typical Gate Charge

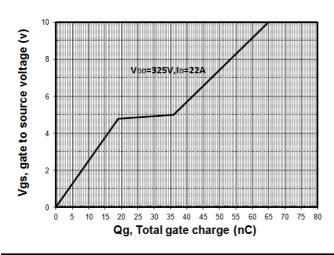


Figure 12. Threshold Voltage vs **Temperature**

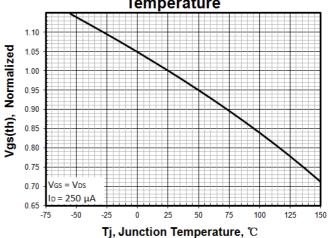


Figure 14. Capacitance vs Vds

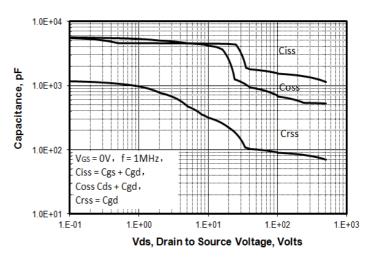
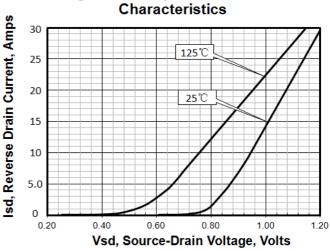


Figure 16.Body Diode Transfer Characteristics





Test Circuits and Waveforms

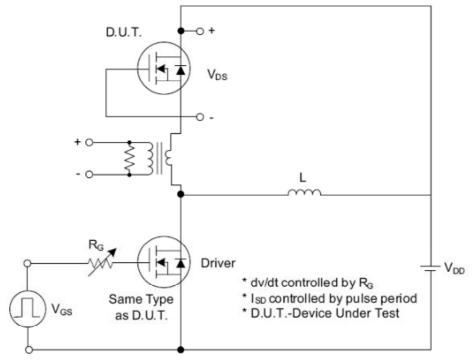


Fig. 1.1 Peak Diode Recovery dv/dt Test Circuit

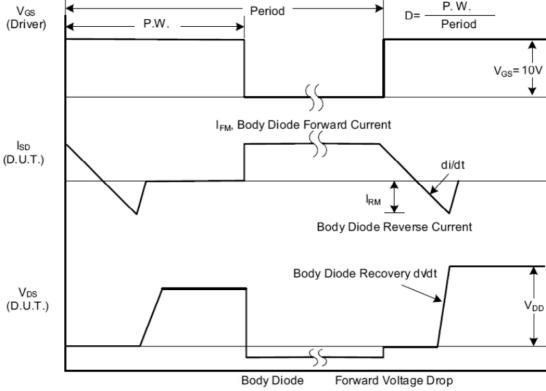


Fig. 1.2 Peak Diode Recovery dv/dt Waveforms



Test Circuits and Waveforms (Cont.)

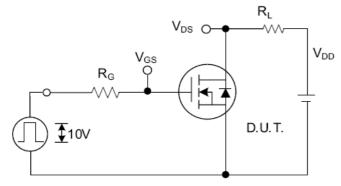


Fig. 2.1 Switching Test Circuit

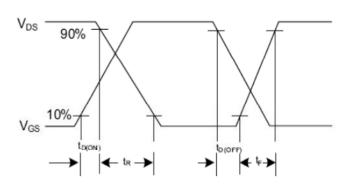


Fig. 2.2 Switching Waveforms

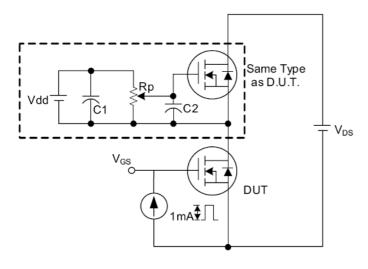


Fig. 3 . 1 Gate Charge Test Circuit

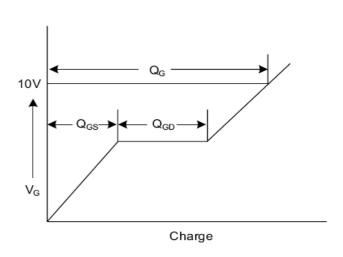


Fig. 3.2 Gate Charge Waveform

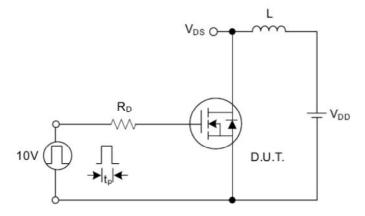


Fig. 4.1 Unclamped Inductive Switching Test Circuit

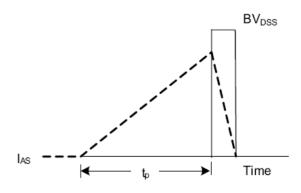


Fig. 4.2 Unclamped Inductive Switching Waveforms



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